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Zone Centre Phonon Mode Behavior of Wurtzite Phase of Ternary Nitrides

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Abstract: The group-III nitrides have been acknowledged as noteworthy materials for researchers in recent times for their extra ordinary properties and applications. The vital property of these materials is their wide and direct band gap, which can also be customized by doping. A common feature of these device structures is the applicability of ternary alloys. Despite of the wide range of the ternary alloys of group-III nitrides only few have been discussed. So in this study we have studied zone centre phonon mode behavior of the ternary alloys $In_xGa_{1-x}N$ and $Al_xGa_{1-x}N$ for wurtzite phase using de Launey Angular force constant model. The optical phonon modes at zone centre have been found for $In_xGa_{1-x}N$ and $Al_xGa_{1-x}N$. The content of Al and In in alloy is in the range 0 < x < 1. The one mode behavior has been observed for both the alloys and it is found that for wurtzite phase of $In_xGa_{1-x}N$ continuous decreases in magnitude of phonon frequency with the increase in the content of In and for wurtzite phase of $Al_xGa_{1-x}N$ increase in magnitude of phonon frequency is reported with increase in content of Al, which is due to the fact that frequency varies inversely proportional to the mass, as content of In increases mass of alloy while content of Al decreases the mass of alloy.

I. INTRODUCTION

Group-III nitrides are the fundamental building blocks of laser diodes (LDs), light emitting diodes (LEDs), emitter and receiver of optoelectronic devices. An extraordinary property of group-III nitride semiconductors is the utilization of their ternary alloys. The direct band gap of group-III nitride alloys can be continuously extended from infrared (IR) region to ultraviolet (UV) region with suitable concentration of doping. The energy gaps of In_xGa_{1-x}N alloy provides an outstanding match to the full solar band which unlock an chance for high efficiency multifunction solar cells with flexibility of selection of gaps (Wu et al., 2003). Al_xGa_{1-x}N can also be used for water purification. These alloys can meet the requirement of next generation electronic equipment, high frequency, microwave power appliances of high power, smaller dimensions and work under ambient conditions. In recent studies the optical modes of In_xGa_{1-x}N in cubic phase by molecular beam epitaxy were experimentally studied by using Raman spectroscopy and it is observed that the optical modes show a one-mode behavior and their frequency vary linearly with alloy composition (Teles et al., 2004, Santos et al., 2002). The infrared transmission study of both the phases i.e. cubic and wurtzite phase of Al_xGa_{1-x}N has been studied by (Ibanez et al., 2008) in composition range 0<x<0.3 and reported one mode behavior for Al_xGa_{1-x}N. To improve the performance of the devices the understanding of the light emission mechanism is essential. Even these materials have such outstanding properties but ternary alloys of cubic and wurtzite phase have been studied much less efficiently. The knowledge of basic properties of these materials is lacking. Therefore, in the present study the zone centre phonon mode behavior of various optical modes of ternary alloys Al_xGa_{1-x}N and In_xGa_{1-x}N for wurtzite phase have been investigated by using de Launey angular force constant model to understand the miscibility of one in another with varying composition 0<x<1. The zone centre phonon frequency of these alloys is calculated and results are found to be in admirable agreement with existing experimental and theoretical results with large range of composition.

II. THEORY

The creation of mixed crystal with special proportion of two undoped crystals results in a fresh set of crystal with physical properties which are in-between pure end members depending upon the composition of pure crystals. The properties may change in different manner with variation of composition. In some mixed crystals properties changes monotonically linearly as a function of composition while in some cases the properties may vary non-linearly (may be slightly non linearly or highly non-linear manner). In some cases, properties are different from the properties of parent crystals at all and these properties are unique to mixed crystals only.

In this study by using de Launey Angular force constant model we have obtained the frequency at zone centre of the In and Al doped GaN with composition varying from 0 to 1. Here two parts of the Interatomic interactions are considered: Central interaction (ion-ion radial interaction), which act along the line joining the centres of two neighbors and angular force which depends upon the



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angle which the line joining the moving atoms makes with the line joining their equilibrium position. These forces are considered for first and second nearest neighbors. We shall let α_1 and α'_1 denote the force constant associated with central force and angular force of the nearest neighbor, while α_2 and α'_2 denote the force constant associated with central and angular force next nearest neighbours. In DAF model by using the coordinates and direction cosines of the neighbors, in the equation of motion given below

$$\vec{F} = -\alpha' (\vec{S}_0 - \vec{S}_i) - (\alpha - \alpha') (\hat{\zeta}_i) [\hat{\zeta}_i (\vec{S}_0 - \vec{S}_i)]$$

Where S_{o} and S_{i} are the displacements of the reference atom and ith atom.

 $\hat{\zeta}$ is the unit vector along the line joining the reference atom to the ith atom.

By using above equation a dynamical matrix of 6x6 is formed and is given by the solution of characteristic equation

$$[d(k) - m\omega^2 I] = 0$$

Where D(k) is (12x12) dynamical matrix in case of wurtzite phase, as wurtzite structure has four atoms per unit cell and I is unit vector. The obtained dynamical matrix of $(12 ext{ x } 12)$ is solved at center of the zone to get relation between some vibrational frequencies and force constants. The following relations between force constants and some important vibrational frequencies are obtained.

$$\frac{4}{3}\left(\alpha_{1}+2\alpha_{1}^{'}\right)=\frac{m_{1}m_{2}}{m_{1}+m_{2}}\omega_{E_{1}(TO)}^{2}$$

$$\frac{4}{3}\left(\alpha_{1}+2\alpha_{1}^{'}\right)+2\left(4\alpha_{2}+2\alpha_{2}^{'}\right)=m_{2}\omega_{A_{1}(TO)}^{2}$$

$$4\left(\alpha_{2}^{2}+25(\alpha_{2}^{'})^{2}+10\alpha_{2}\alpha_{2}-\alpha_{1}^{2}\right)+\frac{16}{3}\left(\alpha_{1}+2\alpha_{1}^{'}\right)\left(\alpha_{2}+5\alpha_{2}^{'}+\alpha_{1}\right)$$

$$-\left(\frac{4}{3}\left(\alpha_{1}+2\alpha_{1}^{'}\right)+2\alpha_{1}+10\alpha_{2}^{'}\right)\left(m_{1}+m_{2}\right)\omega_{E_{2}^{h}}^{2}+m_{1}m_{2}\omega_{E_{2}^{h}}^{4}=0$$

$$\alpha_{2}+5\alpha_{2}^{'}+\alpha_{1}^{'}=\frac{m_{1}}{2}\omega_{E_{2}^{f}}^{2}$$

Here m_1 and m_2 are the mass of X (Al, Ga, B and In) and N atom respectively. By using the experimental values of the zone centre frequencies, m_1 and m_2 as the input parameter the above equations are solved to calculate force constants at zone centre of the binaries. To calculate the force constants for ternary alloys Vegard's law is used and the involved four force constants and mass of constituent atoms (P and Q) for any ternary alloy $P_xQ_{1-x}N$ are obtained by using Vegard's law as given below.

$$\alpha_{P_{x}Q_{(1-x)}N} = x\alpha_{PN} + (1-x)\alpha_{QN}$$

$$m_{P_{x}Q_{(1-x)}} = xm_{P} + (1-x)m_{Q}$$
5.2

Where m_P and m_Q are the masses of P (P = Al, Ga, In) and Q (Q = Al, Ga, In) and α_{PN} and α_{QN}

 $Table \ I$ Force constants for wurtzite ternary alloy $Al_xGa_{1-x}N$

Alloy	Composition (x)	Fo	Mass of Al _x Ga ₁₋			
		$lpha_1$	$lpha_1'$	α_2	$lpha_2'$	$_{x}(10^{-24} \text{gm})$
Al _x Ga _{1-x} N	0.0	10.5253	2.8951	0.0933	0.2703	116.39
	0.2	10.81086	2.98002	0.21736	0.2583	102.125
	0.4	11.09642	3.06494	0.34142	0.2463	87.858
	0.6	11.38198	3.14986	0.46548	0.2343	73.592
	0.8	11.66754	3.23478	0.58954	0.2223	59.326
	1	11.9531	3.3197	0.7136	0.2103	45.06



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 $Table \ II$ Force constants for wurtzite ternary alloy $In_xGa_{1-x}N$

Alloy	Composition (x)	Force Constant (10 ⁴ dyne cm ⁻¹)				Mass In _x Ga _{1-x}
		$lpha_1$	$lpha_1'$	α_2	$lpha_2'$	(10 ⁻²⁴ gm)
In _x Ga _{1-x} N	0.0	10.5253	2.8951	0.0933	0.2703	116.39
	0.2	1026008	2.65586	0.05014	0.25638	131.462
	0.4	9.994716	2.41662	0.0698	0.24462	146.534
	0.6	9.729424	2.17738	0.03618	0.22854	161.606
	0.8	9.464132	1.93814	-0.0793	0.21462	176.678
	1	9.1992	1.6989	1225	0.2007	191.75

III. RESULTS AND DISCUSSIONS

It is clear from table I and II that as the dopant concentration increases (decreases) the mass of mixture Al_xGa_{1-x} (In_xGa_{1-x}) decreases (increases) and force constants increases (decreases). The larger magnitude of force constants depicts the stronger inter atomic interaction and vice versa. It is clear from figure I that as the concentration of dopant i.e. Al increases in $Al_xGa_{1-x}N$ the magnitude of optical phonon frequencies (E_2 (high), E_1 (TO) and A_1 (TO)) at zone centre increases while in $In_xGa_{1-x}N$ as the concentration of dopant increases the magnitude of all the optical phonon frequencies (E_1 (TO), A_1 (TO) and E_2 (high)) at zone centre decreases which is in harmony with the fact that the stronger interaction leads to greater value of the optical phonon frequency and vice versa (Sinha et al., 2009). It is observed for both the ternary alloys that the optical phonon modes show linear variance the concentration of dopant from one end member to other end member. This shows that these alloys exhibit one mode behavior throughout the whole range of concentration. This variation of optical phonon modes with concentration is in agreement with existing results for E_1 (TO) and A_1 (TO) for $Al_xGa_{1-x}N$ (Liu et al., 1998). In graph I the solid lines represents the results of this work while the circles represent the results of (Ibanez et al., 2008) and rectangles represent results of (Liu S et al., 1998).

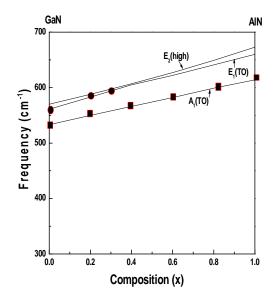


Figure I One mode behavior of wurtzite ternary alloy Al_xGa_{1-x}N.

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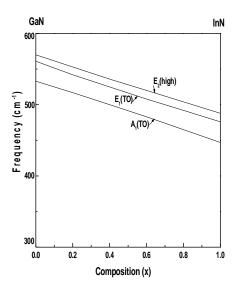


Figure II One mode behavior of wurtzite ternary alloy In_xGa_{1-x}N

REFERENCES

- [1] Bechshedt F., Furthmulklar J., Wagner J. M.: Electronic and vibrational propertirs of group-III nitrides; Ab intio studies Phys. Stat. Sol. (C) 6, 1732-1749 2003.
- [2] Bootz B., Osten W. and Uhle N. Long-Wavelength Optical Phonons of AgBrxCl₁-x Mixed Crystals Phys. Stat. Sol. B. 66: 169-174 1974.
- [3] C.H.Chen, Y.F.Chen, An Shih, S.C.Lee and H.X.Jiang, Appl. Phys. Lett. 78, 3035 2001.
- [4] Cros, H. Angerer, O. Ambacher, R. Hopler, T. Metzger, and Stutzmann M. Raman study of the optical phonons in AlxGa_{1-xN} alloys Solid State Communications, 104: 35-39, 1997.
- [5] Dutta M., Alexson D., Bergman L., Nemanich R. J., Dupuis R., Kim K.W., Komirenko S. and Stroscio M. *Phonons in III-V nitrides: confined phonons and interface phonons* Physica E. 11: 277-280, 2001.
- [6] Enling Li, Hou L., Li L., Liu M., Xi M., Wang X. and Dai Y. The study of electronic structures and optical properties of Al doped GaN J Phys.: Conf. Ser. 276 012044, 2011.
- [7] Hai ying Hing, Guanghan Fan and Tian ming Zhou Acta Phys. Sin 24 1432 2008.
- [8] Harima H., Inoue T., Nakashima S., okumura H., Ishida Y., Yoshida S., Koizumi T., Grille H. and Bechstedt F. *Raman studies on phonon modes in cubic AlGaN alloy* Appl. Phys. Letts. 74 2: 191-193, 1999.
- [9] Jianyun Guo, Guang Zheng and Kaihua He Acta Phys. Sin 57 3740 2008.
- [10] Marmalyuk, R. Kh. Akchurin and V A Gorbylev: Evaluation of elastic constants of AlN, GaN InN Inorganic materials, 34 7 691-695 1997.
- [11] Ming S. Liu, Y.Z.Tong, Les A Bursill, S. Prawar, K.W. Nungent, G. Y. zhang, Solid state communication 108 10765-768 (1998).
- [12] Mohamed Henini Nitride Electronics III-Vs Review 12 5 1999.
- [13] Nakamura S. III-V nitride-based light- emitting diodes Diamond and related materials. 5: 496-500 1996.
- [14] S.K. Novikov, C. R. Staddon, F. Luckert, P.RE. Edwards, R. W. Martin, A. J. Kent and C. T. Foxon journal of crystal growth 350 80-84, 2012.
- [15] Santos A. M., Silva E. C. F, Noriega O. C., Alves H. W. L., Alves J. L. A. and Leite J. R. Vibrational Properties of Cubic Al_xGa_{1-x}N and In_xGa_{1-x}N Ternary Alloys phys. Stat. sol. 232 182, 2002.
- [16] T. Frey, D. J. As, M. Bartels, A. Pawlis, k. Lischka, A. Tabata, J. R. L. Fernandez, M.T.O. Silva, J. R. Leite, C Haug and R. Brenn Journalk of applied physics 89 no5 2631(2001).
- [17] Tabata A., Leite J.R., Lima A.P., Silveria E., lemos V., Frey T., As D.J., Schikora D. and Lischka K. Raman phonon modes of zinc blende In_xGa_{1-x}N alloy epitaxial layers. Appl. Phys. Lett. 75 1095, 1999.
- [18] Teles L. K., Marques M., Scolfaro L. M. R., Leite J. R. Phase separation and ordering in group-III nitride alloys Ferreira Braz. J Phys. 34, 2004.
- [19] Youwang huan, Hui Xu, Dan Zhang, PengHua: The dielectric and dynamical properties of zinc blende BN, AlN and GaNfrom first principle calculation Sci. china ser. G-phys. Mech. Astron.51 (2008) 1037-1045.
- [20] Wu J., Walukiewicz W., Yu K.M.,. Ager J.W., Li S.X., Haller E.E., Lu H., Schaff W. J. 2003. Universal bandgap bowing in group-III nitride alloys. Solid State Comm. 127: 411–414.
- [21] Ibanez J., Hemandes S., Alarcon-Liado E., Cusco R., Artus L., Novikov S. V., Foxon C. T. and Calleja E. 2008. Far-infrared transmission in GaN, AlN and AlGaN thin films grown by molecular beam epitaxy. J. of Appl. Phys. 104 033455.
- [22] Liu M. S., Tong Y. Z., Bursill L. A., Prawer S., Nugent K.W. and Zhang G. Y. 1998. Dependence on Al concentration of the optical phonons of Al_xGa_{1-x}N films. Solid State Comm. 108 10 765-768.









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